

## CD4724BC 8-Bit Addressable Latch

### General Description

The CD4724BC is an 8-bit addressable latch with three address inputs (A0-A2), an active low enable input ( $\bar{E}$ ), active high clear input ( $C_L$ ), a data input (D) and eight outputs (Q0-Q7).

Data is entered into a particular bit in the latch when that is addressed by the address inputs and the enable ( $\bar{E}$ ) is LOW. Data entry is inhibited when enable ( $\bar{E}$ ) is HIGH.

When clear ( $C_L$ ) and enable ( $\bar{E}$ ) are HIGH, all outputs are LOW. When clear ( $C_L$ ) is HIGH and enable ( $\bar{E}$ ) is LOW, the channel demultiplexing occurs. The bit that is addressed has an active output which follows the data input while all unaddressed bits are held LOW. When operating in the addressable latch mode ( $\bar{E} = C_L = \text{LOW}$ ), changing more than one bit of the address could impose a transient wrong address. Therefore, this should only be done while in the memory mode ( $\bar{E} = \text{HIGH}$ ,  $C_L = \text{LOW}$ ).

### Features

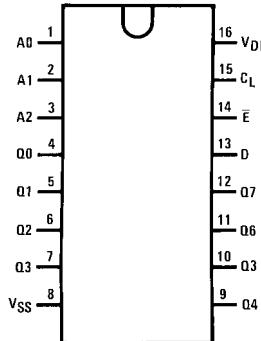
- Wide supply voltage range: 3.0V to 15V
- High noise immunity: 0.45  $V_{DD}$  (typ.)
- Low power TTL compatibility:
  - fan out of 2 driving 74L or 1 driving 74LS
- Serial to parallel capability
- Storage register capability
- Random (addressable) data entry
- Active high demultiplexing capability
- Common active high clear

### Ordering Code:

Order Number	Package Number	Package Description
CD4724BCM	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
CD4724BCN	N16E	16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

### Connection Diagram

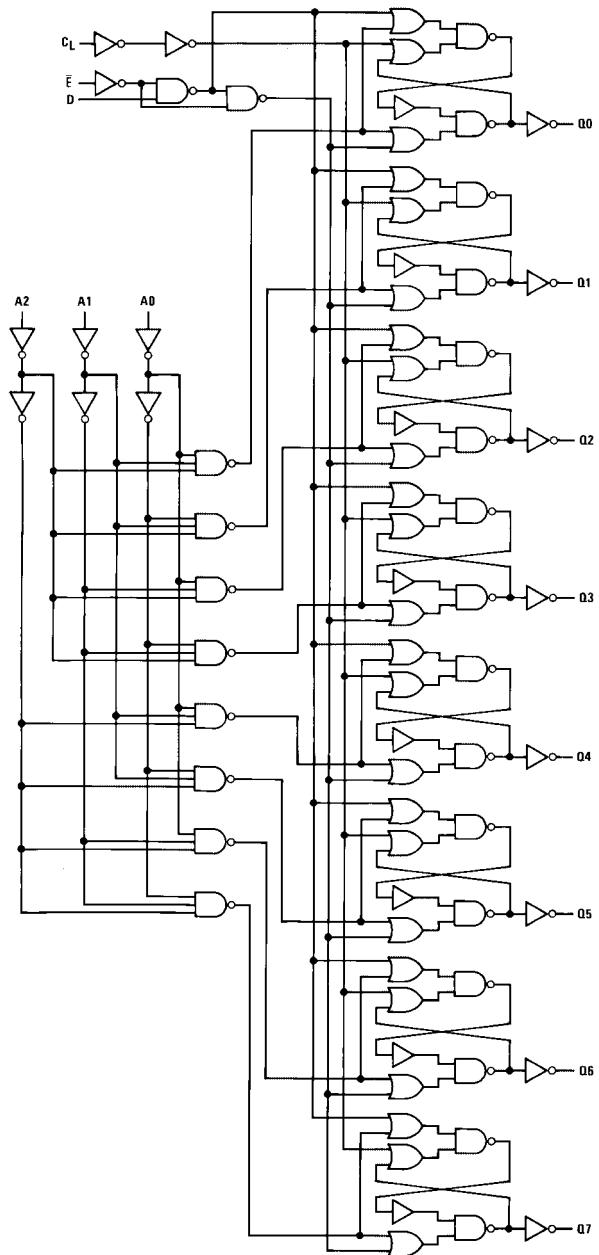


Top View

### Truth Table

Mode Selection				
$\bar{E}$	$C_L$	Addressed Latch	Unaddressed Latch	Mode
L	L	Follows Data	Holds Previous Data	Addressable Latch
H	L	Hold Previous Data	Holds Previous Data	Memory
L	H	Follows Data	Reset to "0"	Demultiplexer
H	H	Reset to "0"	Reset to "0"	Clear

## Logic Diagram



**Absolute Maximum Ratings**(Note 1)

(Note 2)

DC Supply Voltage ( $V_{DD}$ )	-0.5V to +18 V <sub>DC</sub>
Input Voltage ( $V_{IN}$ )	-0.5V to $V_{DD}$ +0.5 V <sub>DC</sub>
Storage Temperature ( $T_S$ )	-65°C to +150°C
Power Dissipation ( $P_D$ )	
Dual-In-Line	700 mW
Small Outline	500 mW
Lead Temperature ( $T_L$ )	
(Soldering, 10 seconds)	260°C

**Recommended Operating Conditions**(Note 2)

DC Supply Voltage ( $V_{DD}$ )	3.0V to 15 V <sub>DC</sub>
Input Voltage ( $V_{IN}$ )	0V to $V_{DD}$ V <sub>DC</sub>
Operating Temperature Range ( $T_A$ )	-55°C to +125°C

**Note 1:** "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed; they are not meant to imply that the devices should be operated at these limits. The tables of "Recommended Operating Conditions" and Electrical Characteristics" provide conditions for actual device operation.

**Note 2:**  $V_{SS} = 0V$  unless otherwise specified.

**DC Electrical Characteristics**(Note 2)

Symbol	Parameter	Conditions	-55°C		+25°C			+125°C		Units
			Min	Max	Min	Typ	Max	Min	Max	
$I_{DD}$	Quiescent Device Current	$V_{DD} = 5V$		5		0.02	5		150	μA
		$V_{DD} = 10V$		10		0.02	10		300	
		$V_{DD} = 15V$		20		0.02	20		600	
$V_{OL}$	LOW Level Output Voltage	$ I_O  \leq 1 \mu A$								V
		$V_{DD} = 5V$	0.05		0	0.05			0.05	
		$V_{DD} = 10V$	0.05		0	0.05			0.05	
		$V_{DD} = 15V$	0.05		0	0.05			0.05	
$V_{OH}$	HIGH Level Output Voltage	$ I_O  \leq 1 \mu A$								V
		$V_{DD} = 5V$	4.95		4.95	5.0		4.95		
		$V_{DD} = 10V$	9.95		9.95	10		9.95		
		$V_{DD} = 15V$	14.95		14.95	15		14.95		
$V_{IL}$	LOW Level Input Voltage	$V_{DD} = 5V, V_O = 0.5V$ or $4.5V$		1.5		2.25	1.5		1.5	V
		$V_{DD} = 10V, V_O = 1V$ or $9V$		3.0		4.5	3.0		3.0	
		$V_{DD} = 15V, V_O = 1.5V$ or $13.5V$		4.0		6.75	4.0		4.0	
$V_{IH}$	HIGH Level Input Voltage	$V_{DD} = 5V, V_O = 0.5V$ or $4.5V$	3.5		3.5	2.75		3.5		V
		$V_{DD} = 10V, V_O = 1V$ or $9V$	7.0		7.0	5.5		7.0		
		$V_{DD} = 15V, V_O = 1.5V$ or $13.5V$	11.0		11.0	8.25		11.0		
$I_{OL}$	LOW Level Output Current (Note 3)	$V_{DD} = 5V, V_O = 0.4V$	0.64		0.51	0.88		0.36		mA
		$V_{DD} = 10V, V_O = 0.5V$	1.6		1.3	2.25		0.9		
		$V_{DD} = 15V, V_O = 1.5V$	4.2		3.4	8.8		2.4		
$I_{OH}$	HIGH Level Output Current (Note 3)	$V_{DD} = 5V, V_O = 4.6V$	-0.64		-0.51	-0.88		-0.36		mA
		$V_{DD} = 10V, V_O = 9.5V$	-1.6		-1.3	-2.25		-0.9		
		$V_{DD} = 15V, V_O = 13.5V$	-4.2		-3.4	-8.8		-2.4		
$I_{IN}$	Input Current	$V_{DD} = 15V, V_{IN} = 0V$		-0.1		-10 <sup>-5</sup>	-0.1		-1.0	μA
		$V_{DD} = 15V, V_{IN} = 15V$		0.1		10 <sup>-5</sup>	0.1		1.0	

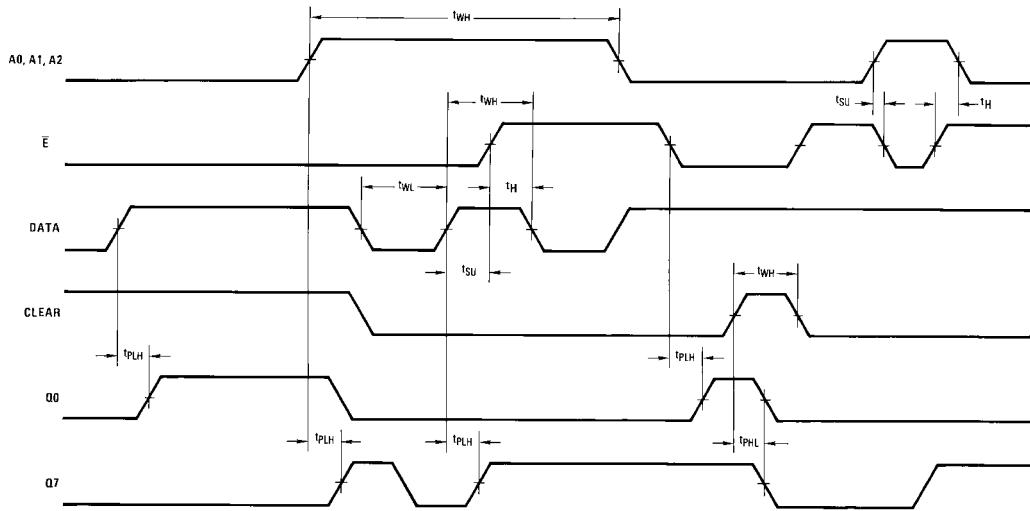
**Note 3:**  $I_{OL}$  and  $I_{OH}$  are tested one output at a time.

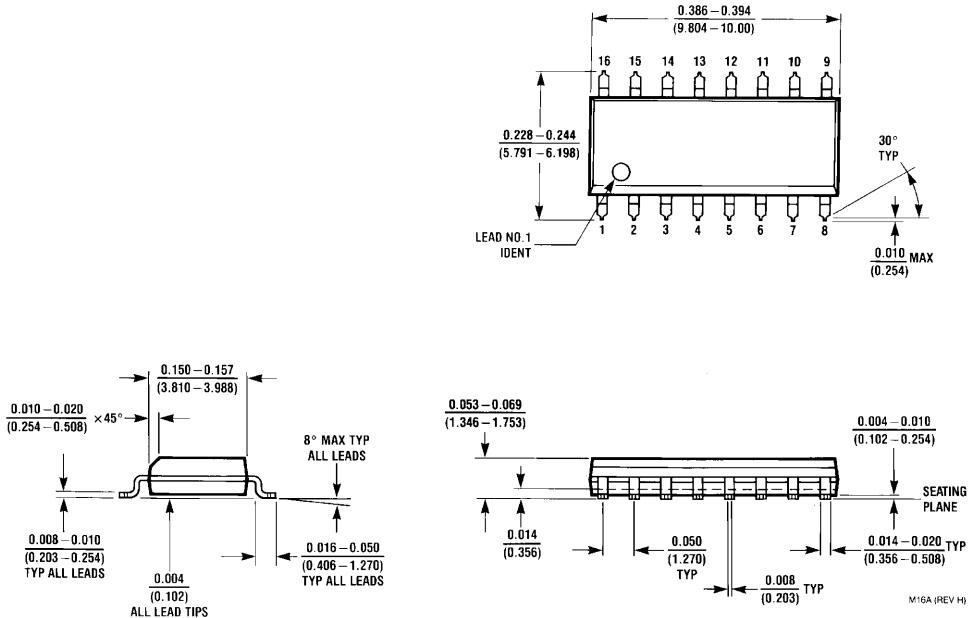
**AC Electrical Characteristics** (Note 4) $T_A = 25^\circ\text{C}$ ,  $C_L = 50 \text{ pF}$ ,  $R_L = 200\text{k}$ , Input  $t_r = t_f = 20 \text{ ns}$ , unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$t_{PHL}, t_{PLH}$	Propagation Delay Data to Output	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		200 75 50	400 150 100	ns
$t_{PLH}, t_{PHL}$	Propagation Delay Enable to Output	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		200 80 60	400 160 120	ns
$t_{PHL}$	Propagation Delay Clear to Output	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		175 80 65	350 160 130	ns
$t_{PLH}, t_{PHL}$	Propagation Delay Address to Output	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		225 100 75	450 200 150	ns
$t_{TLH}, t_{TLL}$	Transition Time (Any Output)	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		100 50 40	200 100 80	ns
$t_{WH}, t_{WL}$	Minimum Data Pulse Width	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		100 50 40	200 100 80	ns
$t_{WH}, t_{WL}$	Minimum Address Pulse Width	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		200 100 65	400 200 125	ns
$t_{WH}$	Minimum Clear Pulse Width	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		75 40 25	150 75 50	ns
$t_{SU}$	Minimum Setup Time Data to E	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		40 20 15	80 40 30	ns
$t_H$	Minimum Hold Time Data to E	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		60 30 25	120 60 50	ns
$t_{SU}$	Minimum Setup Time Address to E	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		-15 0 0	50 30 20	ns
$t_H$	Minimum Hold Time Address to E	$V_{DD} = 5\text{V}$ $V_{DD} = 10\text{V}$ $V_{DD} = 15\text{V}$		-50 -20 -15	15 10 5	ns
$C_{PD}$	Power Dissipation Capacitance (Note 5)	Per Package		100		pF
$C_{IN}$	Input Capacitance	Any Input		5.0	7.5	pF

Note 4: AC Parameters are guaranteed by DC correlated testing.

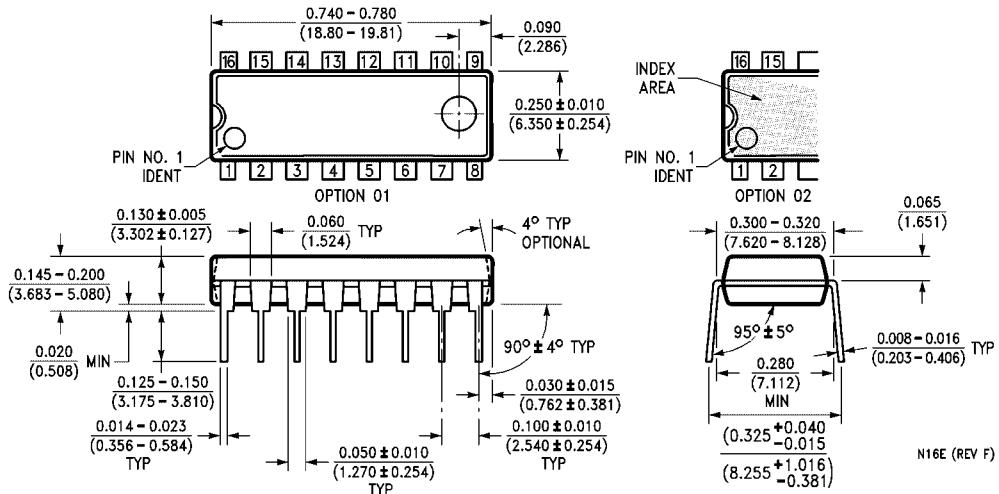
Note 5: Dynamic power dissipation ( $P_D$ ) is given by:  $P_D = (C_{PD} + C_L) V_{CC}^2 f + P_Q$ ; where  $C_L$  = load capacitance;  $f$  = frequency of operation; for further details, see Application Note AN-90, "Family Characteristics".

**Switching Time Waveforms**

**Physical Dimensions** inches (millimeters) unless otherwise noted

16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow  
Package Number M16A

**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide  
Package Number N16E

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